

8-Bit Serial or Parallel-Input/ Serial-Output Shift Register with 3-State Output

High-Performance Silicon-Gate CMOS

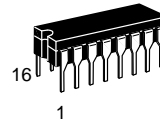
The MC54/74HC589 is similar in function to the HC597, which is not a 3-state device. The device inputs are compatible with standard CMOS outputs, with pullup resistors, they are compatible with LSTTL outputs.

This device consists of an 8-bit storage latch which feeds parallel data to an 8-bit shift register. Data can also be loaded serially (see Function Table). The shift register output, Q_H , is a three-state output, allowing this device to be used in bus-oriented systems.

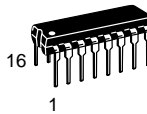
The HC589 directly interfaces with the Motorola SPI serial data port on CMOS MPUs and MCUs.

- Output Drive Capability: 15 LSTTL Loads
- Outputs Directly Interface to CMOS, NMOS, and TTL
- Operating Voltage Range: 2 to 6 V
- Low Input Current: 1 μ A
- High Noise Immunity Characteristic of CMOS Devices
- In Compliance with the Requirements Defined by JEDEC Standard No. 7A
- Chip Complexity: 526 FETs or 131.5 Equivalent Gates

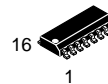
MC54/74HC589



J SUFFIX
CERAMIC PACKAGE
CASE 620-10



N SUFFIX
PLASTIC PACKAGE
CASE 648-08

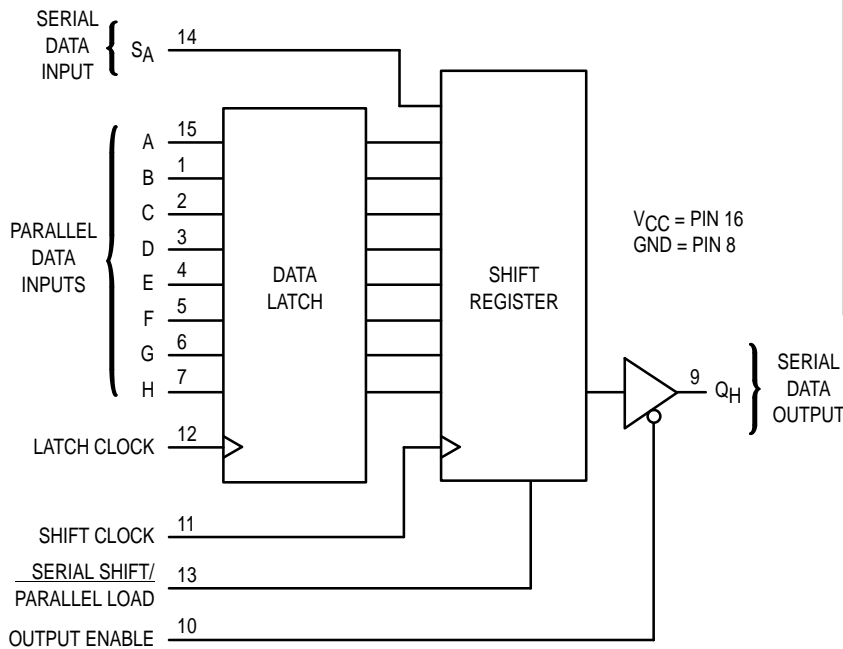


D SUFFIX
SOIC PACKAGE
CASE 751B-05

ORDERING INFORMATION

| | |
|------------|---------|
| MC54HCXXXJ | Ceramic |
| MC74HCXXXN | Plastic |
| MC74HCXXXD | SOIC |

LOGIC DIAGRAM



PIN ASSIGNMENT

| | | | |
|-----|---|----|--------------------------------|
| B | 1 | 16 | VCC |
| C | 2 | 15 | A |
| D | 3 | 14 | S _A |
| E | 4 | 13 | SERIAL SHIFT/ PARALLEL LOAD |
| F | 5 | 12 | LATCH CLOCK |
| G | 6 | 11 | SHIFT CLOCK |
| H | 7 | 10 | OUTPUT ENABLE |
| GND | 8 | 9 | Q _H |



MAXIMUM RATINGS*

| Symbol | Parameter | Value | Unit |
|------------------|---|--------------------------------|------|
| V _{CC} | DC Supply Voltage (Referenced to GND) | - 0.5 to + 7.0 | V |
| V _{in} | DC Input Voltage (Referenced to GND) | - 1.5 to V _{CC} + 1.5 | V |
| V _{out} | DC Output Voltage (Referenced to GND) | - 0.5 to V _{CC} + 0.5 | V |
| I _{in} | DC Input Current, per Pin | ± 20 | mA |
| I _{out} | DC Output Current, per Pin | ± 35 | mA |
| I _{CC} | DC Supply Current, V _{CC} and GND Pins | ± 75 | mA |
| P _D | Power Dissipation in Still Air, Plastic or Ceramic DIP† SOIC Package† | 750 500 | mW |
| T _{stg} | Storage Temperature | - 65 to + 150 | °C |
| T _L | Lead Temperature, 1 mm from Case for 10 Seconds (Plastic DIP or SOIC Package) (Ceramic DIP) | 260 300 | °C |

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high-impedance circuit. For proper operation, V_{in} and V_{out} should be constrained to the range GND ≤ (V_{in} or V_{out}) ≤ V_{CC}. Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or V_{CC}). Unused outputs must be left open.

* Maximum Ratings are those values beyond which damage to the device may occur. Functional operation should be restricted to the Recommended Operating Conditions.
 † Derating — Plastic DIP: -10 mW/°C from 65° to 125°C
 Ceramic DIP: -10 mW/°C from 100° to 125°C
 SOIC Package: -7 mW/°C from 65° to 125°C

For high frequency or heavy load considerations, see Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | Min | Max | Unit | |
|------------------------------------|--|---|-----------------|--------------------|----|
| V _{CC} | DC Supply Voltage (Referenced to GND) | 2.0 | 6.0 | V | |
| V _{in} , V _{out} | DC Input Voltage, Output Voltage (Referenced to GND) | 0 | V _{CC} | V | |
| T _A | Operating Temperature, All Package Types | - 55 | + 125 | °C | |
| t _r , t _f | Input Rise and Fall Time (Figure 1) | V _{CC} = 2.0 V V _{CC} = 4.5 V V _{CC} = 6.0 V | 0 0 0 | 1000 500 400 | ns |

DC ELECTRICAL CHARACTERISTICS (Voltages Referenced to GND)

| Symbol | Parameter | Test Conditions | V _{CC} V | Guaranteed Limit | | | Unit |
|-----------------|--|---|----------------------|------------------|--------|---------|------|
| | | | | - 55 to 25°C | ≤ 85°C | ≤ 125°C | |
| V _{IH} | Minimum High-Level Input Voltage | V _{out} = 0.1 V or V _{CC} - 0.1 V I _{out} ≤ 20 μA | 2.0 | 1.5 | 1.5 | 1.5 | V |
| | | | 4.5 | 3.15 | 3.15 | 3.15 | |
| | | | 6.0 | 4.2 | 4.2 | 4.2 | |
| V _{IL} | Maximum Low-Level Input Voltage | V _{out} = 0.1 V or V _{CC} - 0.1 V I _{out} ≤ 20 μA | 2.0 | 0.3 | 0.3 | 0.3 | V |
| | | | 4.5 | 0.9 | 0.9 | 0.9 | |
| | | | 6.0 | 1.2 | 1.2 | 1.2 | |
| V _{OH} | Minimum High-Level Output Voltage | V _{in} = V _{IH} or V _{IL} I _{out} ≤ 20 μA | 2.0 | 1.9 | 1.9 | 1.9 | V |
| | | | 4.5 | 4.4 | 4.4 | 4.4 | |
| | | V _{in} = V _{IH} or V _{IL} I _{out} ≤ 6.0 mA I _{out} ≤ 7.8 mA | 4.5 | 3.98 | 3.84 | 3.70 | |
| | | | 6.0 | 5.48 | 5.34 | 5.20 | |
| V _{OL} | Maximum Low-Level Output Voltage | V _{in} = V _{IH} I _{out} ≤ 20 μA | 2.0 | 0.1 | 0.1 | 0.1 | V |
| | | | 4.5 | 0.1 | 0.1 | 0.1 | |
| | | V _{in} = V _{IH} or V _{IL} I _{out} ≤ 6.0 mA I _{out} ≤ 7.8 mA | 4.5 | 0.26 | 0.33 | 0.40 | |
| | | | 6.0 | 0.26 | 0.33 | 0.40 | |
| I _{in} | Maximum Input Leakage Current | V _{in} = V _{CC} or GND | 6.0 | ± 0.1 | ± 1.0 | ± 1.0 | μA |
| I _{OZ} | Maximum Three-State Leakage Current | Output in High-Impedance State V _{in} = V _{IL} or V _{IH} V _{out} = V _{CC} or GND | 6.0 | ± 0.5 | ± 5.0 | ± 10 | μA |
| I _{CC} | Maximum Quiescent Supply Current (per Package) | V _{in} = V _{CC} or GND I _{out} = 0 μA | 6.0 | 8 | 80 | 160 | μA |

NOTE: Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

AC ELECTRICAL CHARACTERISTICS ($C_L = 50$ pF, Input $t_r = t_f = 6$ ns)

| Symbol | Parameter | VCC V | Guaranteed Limit | | | Unit |
|--------------------------|---|----------|------------------|--------|---------|------|
| | | | - 55 to 25°C | ≤ 85°C | ≤ 125°C | |
| f_{max} | Maximum Clock Frequency (50% Duty Cycle) (Figures 2 and 8) | 2.0 | 6.0 | 4.8 | 4.0 | MHz |
| | | 4.5 | 30 | 24 | 20 | |
| | | 6.0 | 35 | 28 | 24 | |
| t_{PLH} , t_{PHL} | Maximum Propagation Delay, Latch Clock to Q_H (Figures 1 and 8) | 2.0 | 210 | 265 | 315 | ns |
| | | 4.5 | 42 | 53 | 63 | |
| | | 6.0 | 36 | 45 | 54 | |
| t_{PLH} , t_{PHL} | Maximum Propagation Delay, Shift Clock to Q_H (Figures 2 and 8) | 2.0 | 175 | 220 | 265 | ns |
| | | 4.5 | 35 | 44 | 53 | |
| | | 6.0 | 30 | 37 | 45 | |
| t_{PLH} , t_{PHL} | Maximum Propagation Delay, Serial Shift/Parallel Load to Q_H (Figures 4 and 8) | 2.0 | 175 | 220 | 265 | ns |
| | | 4.5 | 35 | 44 | 53 | |
| | | 6.0 | 30 | 37 | 45 | |
| t_{PLZ} , t_{PHZ} | Maximum Propagation Delay, Output Enable to Q_H (Figures 3 and 9) | 2.0 | 150 | 190 | 225 | ns |
| | | 4.5 | 30 | 38 | 45 | |
| | | 6.0 | 26 | 33 | 38 | |
| t_{PZL} , t_{PZH} | Maximum Propagation Delay, Output Enable to Q_H (Figures 3 and 9) | 2.0 | 150 | 190 | 225 | ns |
| | | 4.5 | 30 | 38 | 45 | |
| | | 6.0 | 26 | 33 | 38 | |
| t_{TLH} , t_{THL} | Maximum Output Transition Time, Any Output (Figures 1 and 8) | 2.0 | 60 | 75 | 90 | ns |
| | | 4.5 | 12 | 15 | 18 | |
| | | 6.0 | 10 | 13 | 15 | |
| C_{in} | Maximum Input Capacitance | — | 10 | 10 | 10 | pF |
| C_{out} | Maximum Three-State Output Capacitance (Output in High-Impedance State) | — | 15 | 15 | 15 | pF |

NOTES:

1. For propagation delays with loads other than 50 pF, see Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).
2. Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

| C_{PD} | Power Dissipation Capacitance (Per Package)* | Typical @ 25°C, VCC = 5.0 V | pF |
|----------|--|-----------------------------|----|
| | | 50 | |

* Used to determine the no-load dynamic power consumption: $P_D = C_{PD} V_{CC}^2 f + I_{CC} V_{CC}$. For load considerations, see Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

TIMING REQUIREMENTS (Input $t_r = t_f = 6$ ns)

| Symbol | Parameter | VCC V | Guaranteed Limit | | | Unit |
|------------|---|----------|------------------|--------|---------|------|
| | | | - 55 to 25°C | ≤ 85°C | ≤ 125°C | |
| t_{su} | Minimum Setup Time, A–H to Latch Clock (Figure 5) | 2.0 | 100 | 125 | 150 | ns |
| | | 4.5 | 20 | 25 | 30 | |
| | | 6.0 | 17 | 21 | 26 | |
| t_{su} | Minimum Setup Time, Serial Data Input S_A to Shift Clock (Figure 6) | 2.0 | 100 | 125 | 150 | ns |
| | | 4.5 | 20 | 25 | 30 | |
| | | 6.0 | 17 | 21 | 26 | |
| t_{su} | Minimum Setup Time, Serial Shift/Parallel Load to Shift Clock (Figure 7) | 2.0 | 100 | 125 | 150 | ns |
| | | 4.5 | 20 | 25 | 30 | |
| | | 6.0 | 17 | 21 | 26 | |
| t_h | Minimum Hold Time, Latch Clock to A–H (Figure 5) | 2.0 | 25 | 30 | 40 | ns |
| | | 4.5 | 5 | 6 | 8 | |
| | | 6.0 | 5 | 6 | 7 | |
| t_h | Minimum Hold Time, Shift Clock to Serial Data Input S_A (Figure 6) | 2.0 | 5 | 5 | 5 | ns |
| | | 4.5 | 5 | 5 | 5 | |
| | | 6.0 | 5 | 5 | 5 | |
| t_w | Minimum Pulse Width, Shift Clock (Figure 2) | 2.0 | 80 | 100 | 120 | ns |
| | | 4.5 | 16 | 20 | 24 | |
| | | 6.0 | 14 | 17 | 20 | |
| t_w | Minimum Pulse Width, Latch Clock (Figure 1) | 2.0 | 80 | 100 | 120 | ns |
| | | 4.5 | 16 | 20 | 24 | |
| | | 6.0 | 14 | 17 | 20 | |
| t_w | Minimum Pulse Width, Serial Shift/Parallel Load (Figure 4) | 2.0 | 80 | 100 | 120 | ns |
| | | 4.5 | 16 | 20 | 24 | |
| | | 6.0 | 14 | 17 | 20 | |
| t_r, t_f | Maximum Input Rise and Fall Times (Figure 1) | 2.0 | 1000 | 1000 | 1000 | ns |
| | | 4.5 | 500 | 500 | 500 | |
| | | 6.0 | 400 | 400 | 400 | |

NOTE: Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

FUNCTION TABLE

| Operation | Inputs | | | | | | Resulting Function | | |
|--|---------------|--------------------------------|------------------|------------------|--------------------|---------------------|---------------------|--|-------------------------|
| | Output Enable | Serial Shift/ Parallel Load | Latch Clock | Shift Clock | Serial Input S_A | Parallel Inputs A–H | Data Latch Contents | Shift Register Contents | Output Q_H |
| Force output into high impedance state | H | X | X | X | X | X | X | X | Z |
| Load parallel data into data latch | L | H | \swarrow | L, H, \swarrow | X | a–h | a–h | U | U |
| Transfer latch contents to shift register | L | L | L, H, \swarrow | X | X | X | U | $LR_N \rightarrow SR_N$ | LR_H |
| Contents of input latch and shift register are unchanged | L | H | L, H, \swarrow | L, H, \swarrow | X | X | U | U | U |
| Load parallel data into data latch and shift register | L | L | \swarrow | X | X | a–h | a–h | a–h | h |
| Shift serial data into shift register | L | H | X | \swarrow | D | X | * | $SR_A = D,$ $SR_N \rightarrow SR_{N+1}$ | $SR_G \rightarrow SR_H$ |
| Load parallel data in data latch and shift serial data into shift register | L | H | \swarrow | \swarrow | D | a–h | a–h | $SR_A = D,$ $SR_N \rightarrow SR_{N+1}$ | $SR_G \rightarrow SR_H$ |

LR = latch register contents
 SR = shift register contents
 a–h = data at parallel data inputs A–H
 D = data (L, H) at serial data input S_A

U = remains unchanged
 X = don't care
 Z = high impedance
 * = depends on Latch Clock input

SWITCHING WAVEFORMS

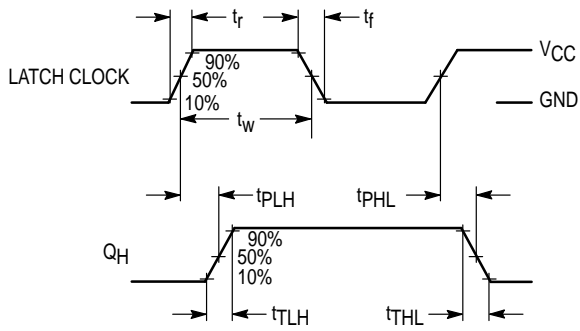


Figure 1. (Serial Shift/Parallel Load = L)

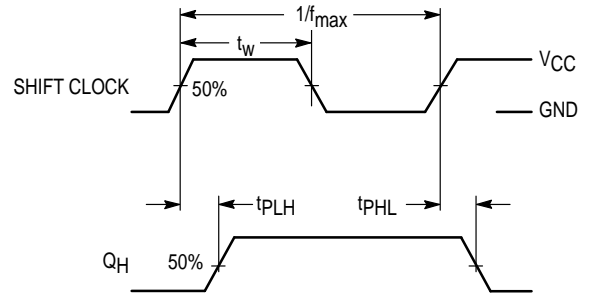


Figure 2. (Serial Shift/Parallel Load = H)

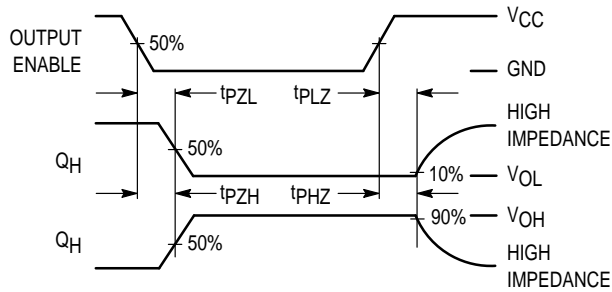


Figure 3.

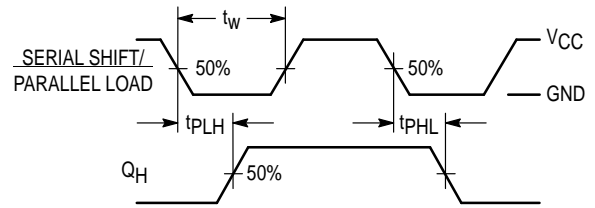


Figure 4.

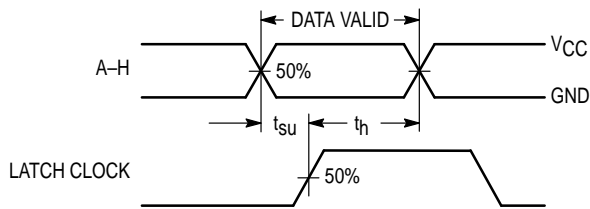


Figure 5.

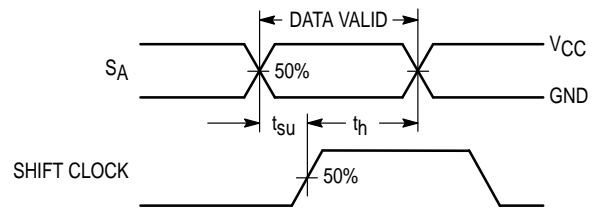


Figure 6.

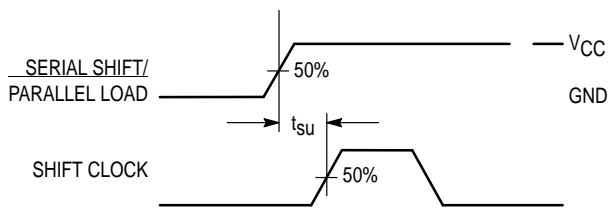
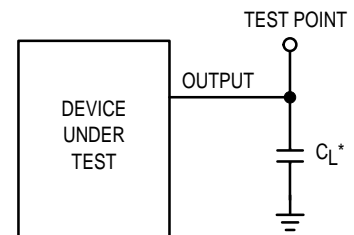


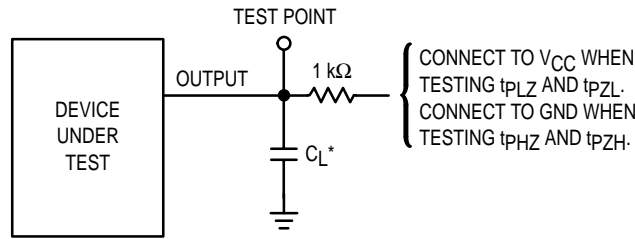
Figure 7.



* Includes all probe and jig capacitance

Figure 8. Test Circuit

TEST CIRCUIT



* Includes all probe and jig capacitance

Figure 9.

PIN DESCRIPTIONS

DATA INPUTS

A, B, C, D, E, F, G, H (Pins 15, 1, 2, 3, 4, 5, 6, 7)

Parallel data inputs. Data on these inputs are stored in the data latch on the rising edge of the Latch Clock input.

SA (Pin 14)

Serial data input. Data on this input is shifted into the shift register on the rising edge of the Shift Clock input if Serial Shift/Parallel Load is high. Data on this input is ignored when Serial Shift/Parallel Load is low.

CONTROL INPUTS

Serial Shift/Parallel Load (Pin 13)

Shift register mode control. When a high level is applied to this pin, the shift register is allowed to serially shift data. When a low level is applied to this pin, the shift register accepts parallel data from the data latch.

Shift Clock (Pin 11)

Serial shift clock. A low-to-high transition on this input shifts data on the serial data input into the shift register and data in stage H is shifted out Q_H, being replaced by the data previously stored in stage G.

Latch Clock (Pin 12)

Data latch clock. A low-to-high transition on this input loads the parallel data on inputs A–H into the data latch.

Output Enable (Pin 10)

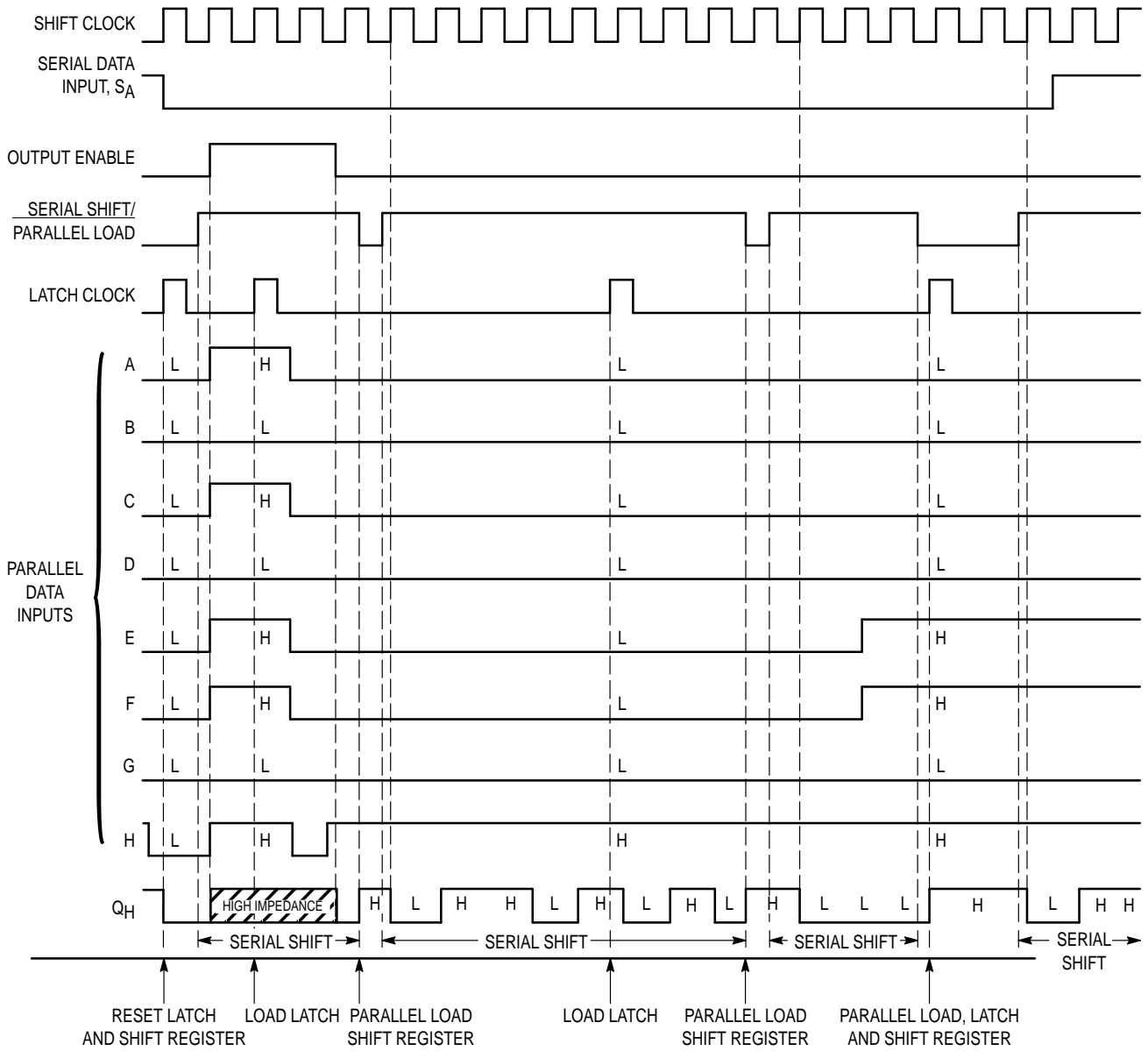
Active-low output enable. A high level applied to this pin forces the Q_H output into the high impedance state. A low level enables the output. This control does not affect the state of the input latch or the shift register.

OUTPUT

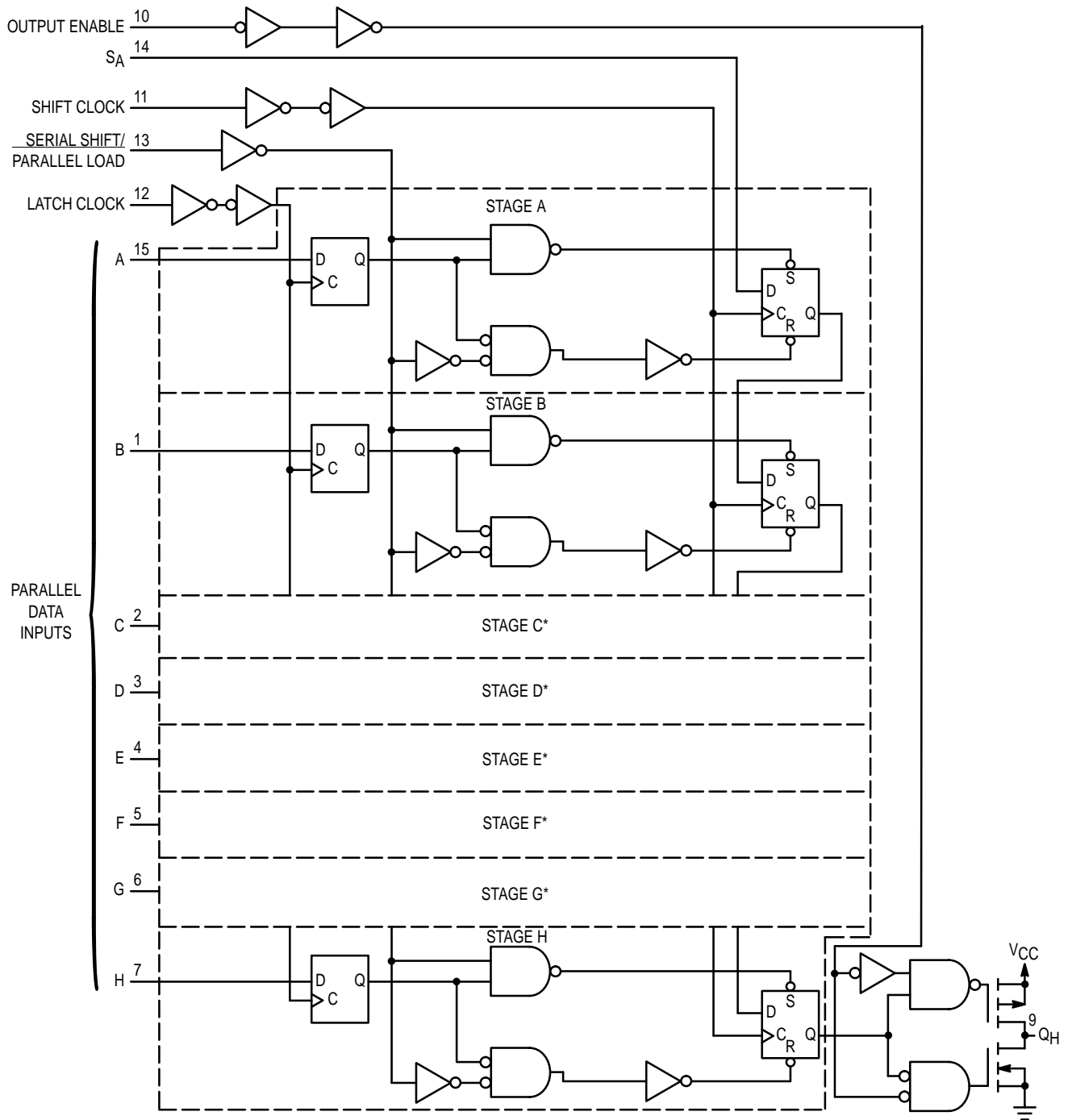
Q_H (Pin 9)

Serial data output. This pin is the output from the last stage of the shift register. This is a 3-state output.


TIMING DIAGRAM



LOGIC DETAIL



*NOTE: Stages C thru G (not shown in detail) are identical to stages A and B above.

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